Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/691,608	CHANG ET AL.	
Examiner	Art Unit	
Sean Weinman	2115	

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	323, 322	1/20/2006	W
710	260	1/20/2006	4
455	574	1/20/2006	Sw
370	311	1/20/2006	gn/
340	7	1/20/2006	60

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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1/20/2006	EXMF
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